Notice of References Cited Application/Control No. 10/796,205 Examiner Jean W. Désir Applicant(s)/Patent Under Reexamination YAMADA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,079,191	07-2006	Kitamura et al.	348/552
*	В	US-6,366,359	04-2002	Garland, Harry T.	358/1.15
*	С	US-4,587,569	05-1986	Nakamura et al.	358/296
*	D	US-4,626,926	12-1986	Nakamura, Shunichi	358/296
*	Е	US-4,635,132	01-1987	Nakamura, Shunichi	358/296
*	F	US-5,019,915	05-1991	Fujito, Shogo	386/46
*	G	US-5,111,285	05-1992	Fujita et al.	358/500
*	Н	US-4,641,980	02-1987	Matsumoto et al.	400/693
*		US-5,235,676	08-1993	Clay et al.	358/1.14
*	J	US-5,377,269	12-1994	Heptig et al.	726/20
*	К	US-7,126,714	10-2006	Inui, Fuyuki	358/1.16
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.